Search Notes



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10/553,734 Examiner

Quang D. Thanh

Applicant(s)/Patent under Reexamination

TANIZAWA ET AL.

Art Unit

3771

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED					
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EAST search (see attached) Inventor names search	5/17/2007	QT
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